

Data sheet acquired from Harris Semiconductor SCHS198A

November 1997 - Revised May 2000

High Speed CMOS Logic Dual 4-Stage Static Shift Register

Features

- Maximum Frequency, Typically 60MHz
 C_L = 15pF, V_{CC} = 5V, T_A = 25°C
- · Positive-Edge Clocking
- Overriding Reset
- · Buffered Inputs and Outputs
- Fanout (Over Temperature Range)
- Wide Operating Temperature Range ...-55°C to 125°C
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
 - 2V to 6V Operation
 - High Noise Immunity: N_{IL} = 30%, N_{IH} = 30% of V_{CC} at V_{CC} = 5V

Description

The 'HC4015 consists of two identical, independent, 4-stage serial-input/parallel-output registers. Each register has independent Clock (CP) and Reset (MR) inputs as well as a single serial Data input. "Q" outputs are available from each of the four stages on both registers. All register stages are D-type, master-slave flip-flops. The logic level present at the Data input is transferred into the first register stage and shifted over one stage at each positive- going clock transition. Resetting of all stages is accomplished by a high level on the reset line.

The device can drive up to 10 low power Schottky equivalent loads. The 'HC4015 is an enhanced version of equivalent CMOS types.

Ordering Information

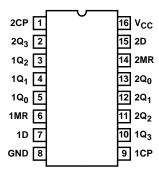
PART NUMBER	TEMP. RANGE (°C)	PACKAGE		
CD54HC4015F3A	-55 to 125	16 Ld CERDIP		
CD74HC4015E	-55 to 125	16 Ld PDIP		

NOTES

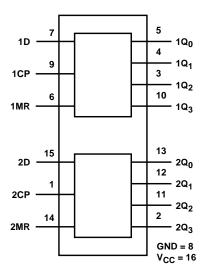
- 1. When ordering, use the entire part number. Add the suffix 96 to obtain the variant in the tape and reel.
- Wafer or die for this part number is available which meets all electrical specifications. Please contact your local TI sales office or customer service for ordering information.

Pinout

CD54HC4015 (CERDIP) CD74HC4015 (PDIP) TOP VIEW



Functional Diagram



TRUTH TABLE

	INPUTS		OUTPUTS							
СР	D	R	Q ₀	Q ₁	Q ₂	Q_3				
1	I	L	L	q' ₀	q '1	q' ₂				
1	h	L	Н	q' ₀	q' ₁	q' ₂				
\downarrow	Х	L	q'o	q'1	q'2	q'3				
Х	Х	Н	L	L	L	L				

NOTES:

H = High Voltage Level

h = High Voltage Level One Set-up Time Prior to the Low to High Clock Transition

L = Low Voltage Level

I = Low Voltage Level One Set-up Time Prior to the Low to High Clock Transition

X = Don't Care.

↑ = Low to High Clock Transition

 \downarrow = High to Low Clock Transition

 $q_n' = L$ ower case letters indicate the state of the referenced output one set-up time prior to the Low to High clock transition.

CD54/74HC4015

Absolute Maximum Ratings

Thermal Information

Thermal Resistance (Typical, Note 3)	θ _{JA} (^o C/W)
PDIP Package	90
Maximum Junction Temperature	
Maximum Storage Temperature Range	65 ⁰ C to 150 ⁰ C
Maximum Lead Temperature (Soldering 10s)	300°C
(SOIC - Lead Tips Only)	

Operating Conditions

Temperature Range, T _A
Supply Voltage Range, V _{CC}
HC Types2V to 6V
DC Input or Output Voltage, V _I , V _O 0V to V _{CC}
Input Rise and Fall Time
2V
4.5V 500ns (Max)
6V

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE

3. θ_{JA} is measured with the component mounted on an evaluation PC board in free air.

DC Electrical Specifications

		TES CONDI		V _{CC}	25°C			-40°C TO 85°C		-55°C TO 125°C				
PARAMETER	SYMBOL	V _I (V)	I _O (mA)	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS		
High Level Input	V _{IH}	-	-	2	1.5	-	-	1.5	-	1.5	-	V		
Voltage				4.5	3.15	-	-	3.15	-	3.15	-	V		
				6	4.2	-	-	4.2	-	4.2	-	V		
Low Level Input	V _{IL}	-	-	2	-	-	0.5	-	0.5	-	0.5	V		
Voltage				4.5	-	-	1.35	-	1.35	-	1.35	V		
				6	-	-	1.8	-	1.8	-	1.8	V		
High Level Output	V _{OH}	V_{IH} or V_{IL}	-0.02	2	1.9	-	-	1.9	-	1.9	-	V		
Voltage CMOS Loads			-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V		
			-0.02	6	5.9	-	-	5.9	-	5.9	-	V		
High Level Output	1		-	-	-	-	-	-	-	-	-	V		
Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V		
TTE Education			-5.2	6	5.48	-	-	5.34	-	5.2	-	V		
Low Level Output V _{OL}	V _{IH} or V _{IL}	0.02	2	-	-	0.1	-	0.1	-	0.1	V			
Voltage CMOS Loads			0.02	4.5	-	-	0.1	-	0.1	-	0.1	V		
OWOO Eddas			0.02	6	-	-	0.1	-	0.1	-	0.1	V		
Low Level Output	1		-	-	-	-	-	-	-	-	-	V		
Voltage TTL Loads					4	4.5	-	-	0.26	-	0.33	-	0.4	V
TIL LOGUS		5.2	6	-	-	0.26	-	0.33	-	0.4	V			
Input Leakage Current	Ι _Ι	V _{CC} or GND	-	6	-	-	±0.1	-	±1	-	±1	μА		
Quiescent Device Current	Icc	V _{CC} or GND	0	6	-	-	8	-	80	-	160	μА		

NOTE: For dual-supply systems theoretical worst case (V_I = 2.4V, V_{CC} = 5.5V) specification is 1.8mA.

CD54/74HC4015

Prerequisite for Switching Specifications

			25°C -40°C TO 85°C		-55°C T				
PARAMETER	SYMBOL	V _{CC} (V)	MIN	MAX	MIN	MAX	MIN	MAX	UNITS
Maximum Clock	f _{MAX}	2	6	-	5	-	4	-	MHz
Frequency		4.5	30	-	24	-	20	-	MHz
		6	35	-	28	-	24	-	MHz
Clock Pulse Width	t _W	2	80	-	100	-	120	-	ns
		4.5	16	-	20	-	24	-	ns
		6	14	-	17	-	20	-	ns
MR Pulse Width	t _W	2	150	-	190	-	225	-	ns
		4.5	30	-	38	-	45	-	ns
		6	26	-	33	-	38	-	ns
MR Recovery Time	tREC	2	50	-	65	-	75	-	ns
		4.5	10	-	13	-	15	-	ns
		6	9	-	11	-	13	-	ns
Set-up Time,	tsul, tsuh	2	60	-	75	-	90	-	ns
Data-In to CP		4.5	12	-	15	-	18	-	ns
		6	10	-	13	-	15	-	ns
Hold Time,	tH	2	0	-	0	-	0	-	ns
Data-In to CP		4.5	0	-	0	-	0	-	ns
		6	0	-	0	-	0	-	ns

Switching Specifications Input t_r , $t_f = 6ns$

	TEST		V _{CC}	25°C			-40°C TO 85°C		-55°C TO 125°C		
PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
Propagation Delay (Figure 1)	t _{PLH,}	C _L = 50pF	2	-	-	175	-	220	-	270	ns
Clock to Q _n	t _{PHL}		4.5	-	-	35	-	44	-	54	ns
		C _L =15pF	5	-	14	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	30	-	37	-	46	ns
MR to Q _n , (Clock High)	t _{PLH} ,	C _L = 50pF	2	-	-	275	-	345	-	415	ns
	t _{PHL}		4.5	-	-	55	-	64	-	83	ns
		C _L =15pF			25	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	47	-	54	-	71	ns
MR to Q _n , (Clock Low)	^t PLH, ^t PHL	C _L = 50pF	2	-	-	325	-	400	-	490	ns
			4.5	-	-	65	-	81	-	98	ns
		C _L =15pF			25	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	55	-	69	-	83	ns
Output Transition Time	t _{TLH} , t _{THL}	C _L = 50pF	2	-	-	75	-	95	-	110	ns
(Figure 1)			4.5	-	-	15	-	19	-	22	ns
			6	-	-	13	-	16	-	19	ns
Input Capacitance	C _{IN}	C _L = 50pF	-	-	-	10	-	10	-	10	pF
Maximum Clock Frequency	f _{MAX}	C _L =15pF	5	-	60	-	-	-	-	-	MHz
Power Dissipation Capacitance (Notes 4, 5)	C _{PD}	C _L =15pF	5	-	43	-	-	-	-	-	pF

NOTES:

- 4. C_{PD} is used to determine the dynamic power consumption, per shift register.

 5. $P_D = V_{CC}^2 f_i + \sum C_L V_{CC}^2$ where f_i = Input Frequency, C_L = Output Load Capacitance, V_{CC} = Supply Voltage.

Test Circuit and Waveform

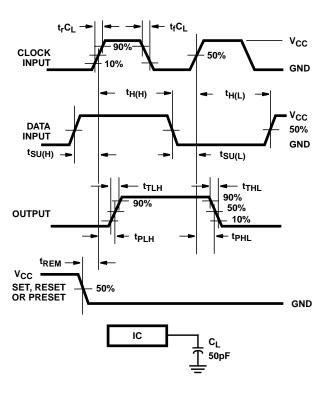


FIGURE 1. HC SETUP TIMES, HOLD TIMES, REMOVAL TIME, AND PROPAGATION DELAY TIMES FOR EDGE TRIGGERED SEQUENTIAL LOGIC CIRCUITS

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